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TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π -MOSV)

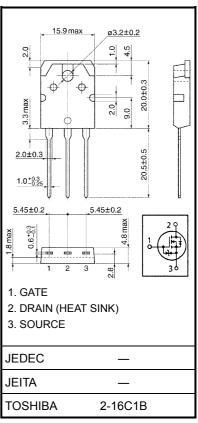
2SK2967

DC–DC Converter, Relay Drive and Motor Drive Applications

- Low drain-source ON resistance $: R_{DS} (ON) = 48 \text{ m}\Omega (typ.)$
- High forward transfer admittance $|Y_{fs}| = 30 \text{ S (typ.)}$
- Low leakage current $: I_{DSS} = 100 \ \mu A \ (max) \ (V_{DS} = 250 \ V)$
- Enhancement-mode $: V_{th} = 1.5 \sim 3.5 \text{ V} (V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

Characteri	stics	Symbol	Rating	Unit
Drain-source voltage		V _{DSS}	250	V
Drain-gate voltage (R	_{GS} = 20 kΩ)	V _{DGR}	250	V
Gate-source voltage		V _{GSS}	±20	V
Drain current	DC (Note 1)	I _D	30	А
	Pulse (Note 1)	I _{DP}	120	А
Drain power dissipation	n (Tc = 25°C)	PD	150	W
Single pulse avalanche	e energy (Note 2)	E _{AS}	925	mJ
Avalanche current		I _{AR}	30	А
Repetitive avalanche e	energy (Note 3)	E _{AR}	15	mJ
Channel temperature		T _{ch}	150	°C
Storage temperature ra	ange	T _{stg}	-55~150	°C



Weight: 4.6 g (typ.)

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch−c)}	0.833	°C / W
Thermal resistance, channel to ambient	R _{th (ch−a)}	50	°C / W

Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2: V_{DD} = 50 V, T_{ch} = 25°C (initial), L = 1.74 mH, I_{AR} = 30 A, R_G = 25 Ω

Note 3: Repetitive rating; Pulse width limited by maximum channel temperature.

This transistor is an electrostatic sensitive device. Please handle with caution. Unit: mm

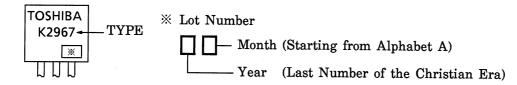
Electrical Characteristics (Ta = 25°C)

Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V		_	±10	μA
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 250 V, V _{GS} = 0 V		_	100	μA
Drain-source breakdown voltage		V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	250	_	_	V
Gate threshold v	voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	1.5	_	3.5	V
Drain-source O	N resistance	R _{DS (ON)}	V _{GS} = 10 V, I _D = 15 A	—	48	68	mΩ
Forward transfe	admittance	Y _{fs}	V _{DS} = 10 V, I _D = 15 A	15	30	_	S
Input capacitance	e	C _{iss}		_	5400		
Reverse transfer capacitance		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		580		pF
Output capacitance		C _{oss}			1900		
Switching time	Rise time	tr	$V_{GS} \stackrel{10V}{}_{0V} \int_{V_{GS}} \stackrel{I_{D}=15A}{}_{OVOUT} \\ \stackrel{I_{D}=15A}$	_	20	_	
	Turn-on time	t _{on}		_	50	_	
	Fall time	t _f		_	35	_	ns
	Turn-off time	t _{off}		_	200	-	
Total gate charge (gate-source plus gate-drain)		Qg			132	_	
Gate-source charge		Q _{gs}	V _{DD} ≈ 200 V, V _{GS} = 10 V, I _D = 30 A		80	_	nC
Gate-drain ("miller") Charge		Q _{gd}			52	—	

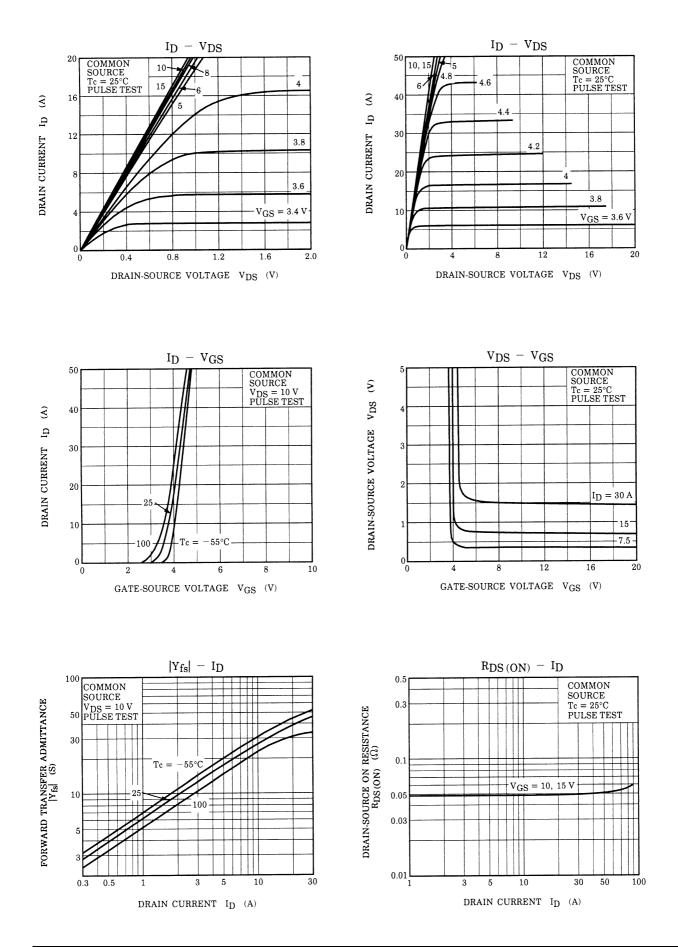
Source–Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	—	_	_	30	А
Pulse drain reverse current (Note 1)	I _{DRP}	—	_	_	120	A
Forward voltage (diode)	V _{DSF}	I _{DR} = 30 A, V _{GS} = 0 V	_	_	-2.0	V
Reverse recovery time	t _{rr}	I _{DR} = 30 A, V _{GS} = 0 V		270		ns
Reverse recovery charge	Qrr	dI _{DR} / dt = 100 A / µs		3.0		μC

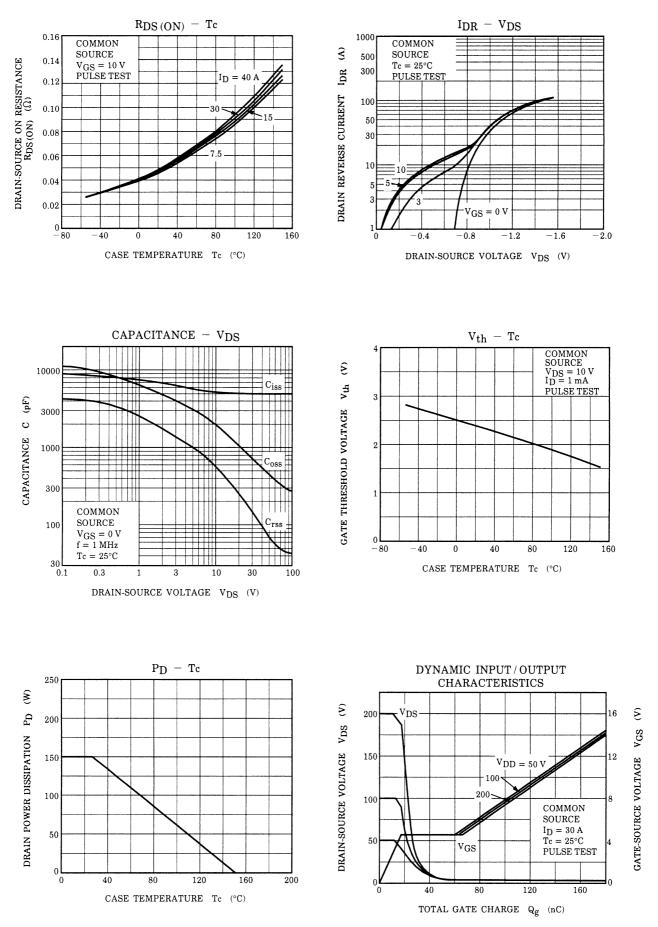
Marking

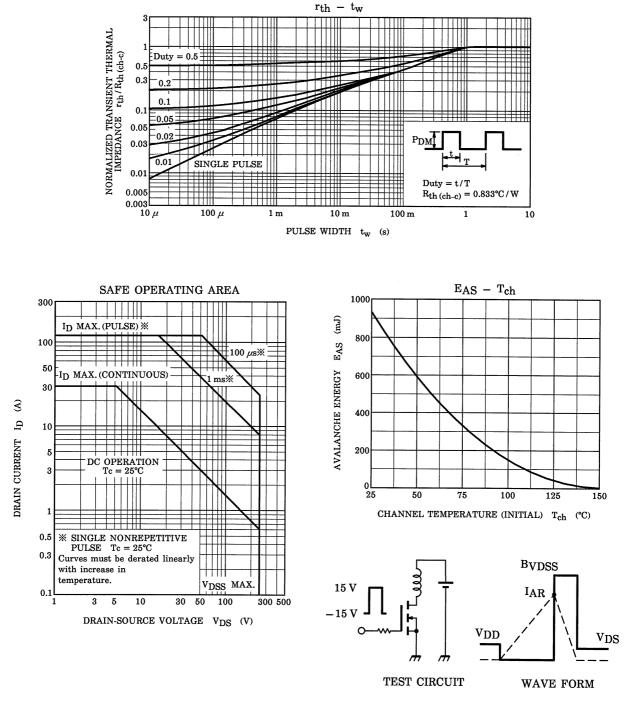


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 $\begin{array}{ll} \mathrm{R_{G}=25~\Omega} \\ \mathrm{V_{DD}=50~V,~L=1.74~mH} \end{array} \quad \mathrm{E_{AS}=}\frac{1}{2} \cdot \mathrm{L} \cdot \mathrm{I}^{2} \cdot \left(\frac{\mathrm{B}\mathrm{VDSS}}{\mathrm{B}\mathrm{VDSS}-\mathrm{VDD}} \right) } \end{array}$

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